N-channel LFPAK 40 V 3.3 mΩ standard level MOSFETRev. 04 — 25 October 2010Product data

Product data sheet

Product profile 1.

1.1 General description

Standard level N-channel MOSFET in LFPAK package qualified to 175 °C. This product is designed and qualified for use in a wide range of industrial, communications and domestic equipment.

1.2 Features and benefits

- Advanced TrenchMOS provides low RDSon and low gate charge
- High efficiency gains in switching power converters

1.3 Applications

- DC-to-DC convertors
- Lithium-ion battery protection
- Load switching

1.4 Quick reference data

- Improved mechanical and thermal characteristics
- LFPAK provides maximum power density in a Power SO8 package
- Motor control
- Server power supplies

Table 1.	Quick reference data					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C	-	-	40	V
I _D	drain current	$T_{mb} = 25 \text{ °C}; V_{GS} = 10 \text{ V};$ see <u>Figure 1</u>	-	-	100	A
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>	-	-	117	W
Tj	junction temperature		-55	-	175	°C
Static cha	aracteristics					
R_{DSon}	drain-source on-state resistance	V _{GS} = 10 V; I _D = 25 A; T _j = 100 °C; see <u>Figure 12</u>	-	-	4.5	mΩ
		$V_{GS} = 10 \text{ V}; I_D = 25 \text{ A};$ T _j = 25 °C; see <u>Figure 13</u>	-	2.6	3.3	mΩ



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Table 1.	Quick reference data co	ontinued					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit	
Dynamic	characteristics						
Q_{GD}	gate-drain charge	V_{GS} = 10 V; I_{D} = 25 A;	-	11.2	-	nC	
Q _{G(tot)}	total gate charge	V _{DS} = 20 V; see <u>Figure 14;</u> see <u>Figure 15</u>	-	49	-	nC	
Avalanch	Avalanche ruggedness						
E _{DS(AL)S}	non-repetitive drain-source avalanche energy		-	-	162	mJ	

2. Pinning information

Table 2.	Pinning	j information		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S	source		-
2	S	source	mb	
3	S	source		
4	G	gate		
mb	D	mounting base; connected to drain	$ \begin{array}{cccccccccccccccccccccccccccccccccccc$	mbb076 S
			SOT669 (LFPAK)	

3. Ordering information

Table 3.	Ordering in	formation		
Type num	ber	Package		
		Name	Description	Version
PSMN3R3	-40YS	LFPAK	plastic single-ended surface-mounted package (LFPAK); 4 leads	SOT669

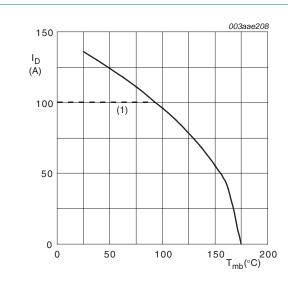
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4. Limiting values

Table 4. Limiting values

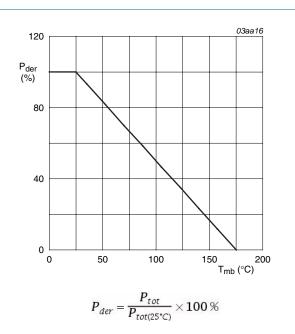
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Мах	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C	-	40	V
V _{DGR}	drain-gate voltage	$T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}; R_{GS} = 20 \text{ k}\Omega$	-	40	V
V _{GS}	gate-source voltage		-20	20	V
I _D	drain current	V_{GS} = 10 V; T_{mb} = 100 °C; see <u>Figure 1</u>	-	97	А
		V_{GS} = 10 V; T_{mb} = 25 °C; see <u>Figure 1</u>	-	100	А
I _{DM}	peak drain current	pulsed; t _p ≤ 10 µs; T _{mb} = 25 °C; see <u>Figure 3</u>	-	546	A
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>	-	117	W
T _{stg}	storage temperature		-55	175	°C
Tj	junction temperature		-55	175	°C
T _{sld(M)}	peak soldering temperature		-	260	°C
Source-drai	n diode				
I _S	source current	T _{mb} = 25 °C	-	100	А
I _{SM}	peak source current	pulsed; $t_p \le 10 \ \mu s$; $T_{mb} = 25 \ ^{\circ}C$	-	546	А
Avalanche r	uggedness				
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; I_D = 100 A; $V_{sup} \le 40$ V; unclamped; R_{GS} = 50 Ω	-	162	mJ



 $V_{GS} \ge 10$ V; (1) Capped at 100 A due to package.

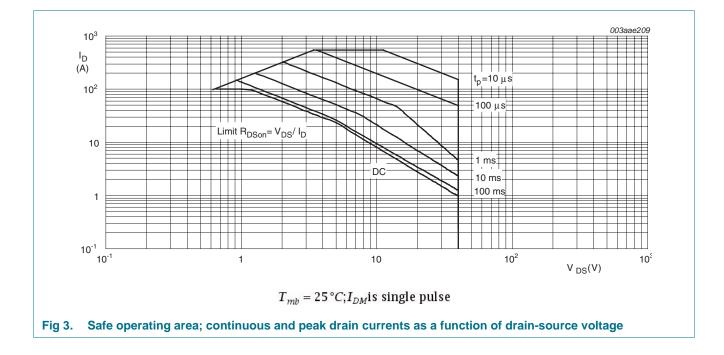
Fig 1. Continuous drain current as a function of mounting base temperature





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Thermal characteristics 5.

Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-mb)}	thermal resistance from junction to mounting base	see Figure 4	-	0.54	1.28	K/W
					003aae210	

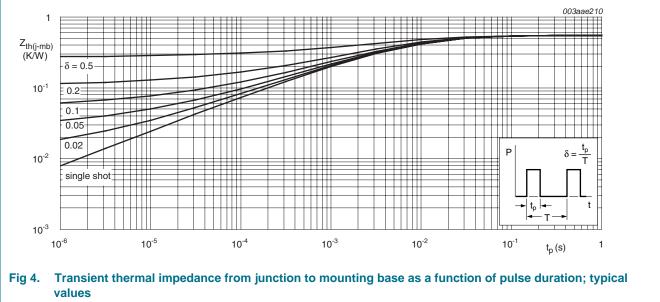


Table 5.

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6. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static chara	cteristics					
V _{(BR)DSS}	drain-source breakdown	I _D = 250 μA; V _{GS} = 0 V; T _j = -55 °C	36	-	-	V
	voltage	$I_D = 250 \ \mu A; \ V_{GS} = 0 \ V; \ T_j = 25 \ ^{\circ}C$	40	-	-	V
V _{GS(th)}	gate-source threshold voltage	I _D = 1 mA; V _{DS} = V _{GS} ; T _j = -55 °C; see <u>Figure 10</u>	-	-	4.6	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 175 \text{ °C};$ see <u>Figure 10</u>	1	-	-	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C};$ see <u>Figure 11</u> ; see <u>Figure 10</u>	2	3	4	V
I _{DSS}	drain leakage current	$V_{DS} = 40 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.02	1	μΑ
		V_{DS} = 40 V; V_{GS} = 0 V; T_j = 125 °C	-	10	100	μΑ
I _{GSS}	gate leakage current	$V_{GS} = 20 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	10	100	nA
		$V_{GS} = -20 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 ^{\circ}\text{C}$	-	10	100	nA
R _{DSon}	drain-source on-state resistance	V _{GS} = 10 V; I _D = 25 A; T _j = 100 °C; see <u>Figure 12</u>	-	-	4.5	mΩ
		V_{GS} = 10 V; I _D = 25 A; T _j = 175 °C; see <u>Figure 12</u>	-	4.7	5.94	mΩ
		V _{GS} = 10 V; I _D = 25 A; T _j = 25 °C; see <u>Figure 13</u>	-	2.6	3.3	mΩ
R _G	internal gate resistance (AC)	f = 1 MHz	-	0.67	-	Ω
Dynamic ch	aracteristics					
Q _{G(tot)}	total gate charge	$I_D = 0 \text{ A}; \text{ V}_{DS} = 0 \text{ V}; \text{ V}_{GS} = 10 \text{ V}$	-	39	-	nC
		$I_D = 25 \text{ A}; V_{DS} = 20 \text{ V}; V_{GS} = 10 \text{ V};$ see <u>Figure 14</u> ; see <u>Figure 15</u>	-	49	-	nC
Q _{GS}	gate-source charge	$I_D = 25 \text{ A}; V_{DS} = 20 \text{ V}; V_{GS} = 10 \text{ V};$	-	13.8	-	nC
Q _{GS(th)}	pre-threshold gate-source charge	see <u>Figure 14</u>	-	8.3	-	nC
Q _{GS(th-pl)}	post-threshold gate-source charge		-	5.5	-	nC
Q _{GD}	gate-drain charge	$I_D = 25 \text{ A}; V_{DS} = 20 \text{ V}; V_{GS} = 10 \text{ V};$ see <u>Figure 14</u> ; see <u>Figure 15</u>	-	11.2	-	nC
V _{GS(pl)}	gate-source plateau voltage	$I_D = 25 \text{ A}; V_{DS} = 20 \text{ V}; \text{ see } \frac{\text{Figure } 14}{\text{Figure } 15}$	-	4.9	-	V
C _{iss}	input capacitance	$V_{DS} = 20 \text{ V}; V_{GS} = 0 \text{ V}; f = 1 \text{ MHz};$	-	2754	-	pF
C _{oss}	output capacitance	T _j = 25 °C; see <u>Figure 16</u>	-	600	-	pF
C _{rss}	reverse transfer capacitance		-	316	-	pF
d(on)	turn-on delay time	$V_{DS} = 20 \text{ V}; \text{ R}_{L} = 0.8 \Omega; \text{ V}_{GS} = 10 \text{ V};$	-	21	-	ns
t _r	rise time	$R_{G(ext)} = 4.7 \Omega$	-	21	-	ns
t _{d(off)}	turn-off delay time		-	38	-	ns
t _f	fall time		-	14	-	ns

Symbol

Source-drain diode

PSMN3R3-40YS

Тур

Max

Unit

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Min

/ _{SD}	source-drain voltage	I _S = 25 A; V _{GS} = 0 V; T _j = 25 °C; see <u>Figure 17</u>	-	0.82	1.2	V
rr	reverse recovery time	I _S = 40 A; dI _S /dt = -100 A/µs;	-	44	-	ns
Q _r	recovered charge	$V_{GS} = 0 \text{ V}; V_{DS} = 20 \text{ V}$	-	48	-	nC
100 I _D (A) 80		003aae211 80 I _D (A) 60 60			003aae212	
60 40 20		40	T _i = 175 °		= 25 °C	
0		$(V) = 4.5$ $V_{DS}(V)^{1}$	2		6 3S(V)	
	$T_j = 25 ^{\circ}C$ Dutput characteristics: drain cu unction of drain-source voltage		$V_{DS} > I_D \times R$ haracteristics gate-source	: drain c		
	Output characteristics: drain cu unction of drain-source voltage		haracteristics	: drain c voltage;		
100 g _{fs} (S)	Output characteristics: drain cu unction of drain-source voltage	b; typical values function of 003aae213 6000 C C	haracteristics	: drain c voltage;	; typical	
100 g _{fs} (S) 80	Output characteristics: drain cu unction of drain-source voltage	203aae213 C (pF)	haracteristics	: drain c voltage;	typical 003aae214	
ft 100 g _{fs} (S) 80 60 40 20	Dutput characteristics: drain cu unction of drain-source voltage	bit function of 003aae213 6000 C C (pF) 4000	haracteristics gate-source	c drain c voltage;	; typical	value
ft 100 g _{fs} (S) 80 60 40 20	Dutput characteristics: drain cu unction of drain-source voltage	a; typical values function of 203aae213 6000 C (pF) 4000 2000 ID 80	haracteristics gate-source	e: drain c voltage;	2003aae214	value

Conditions

Characteristics ... continued Table 6.

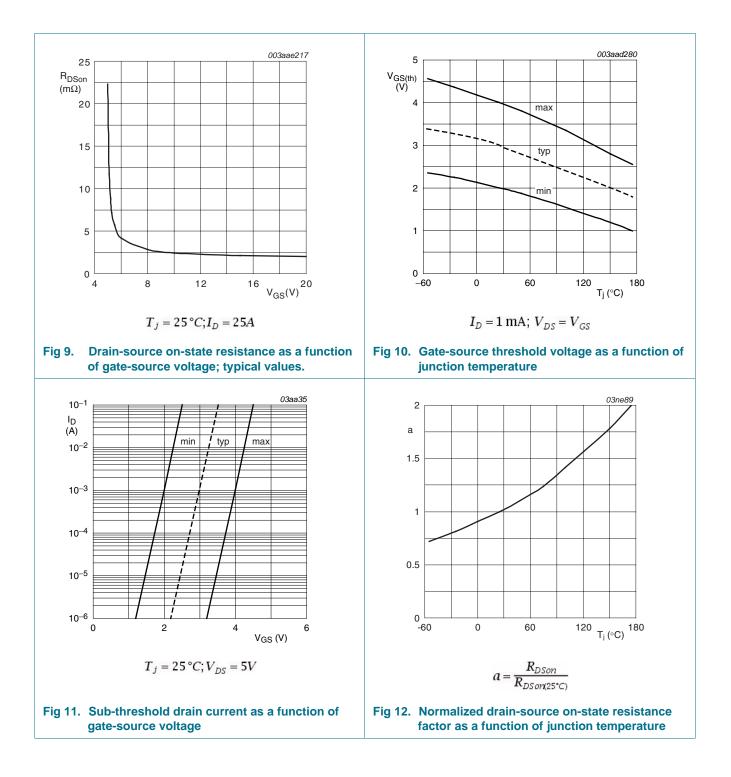
Parameter

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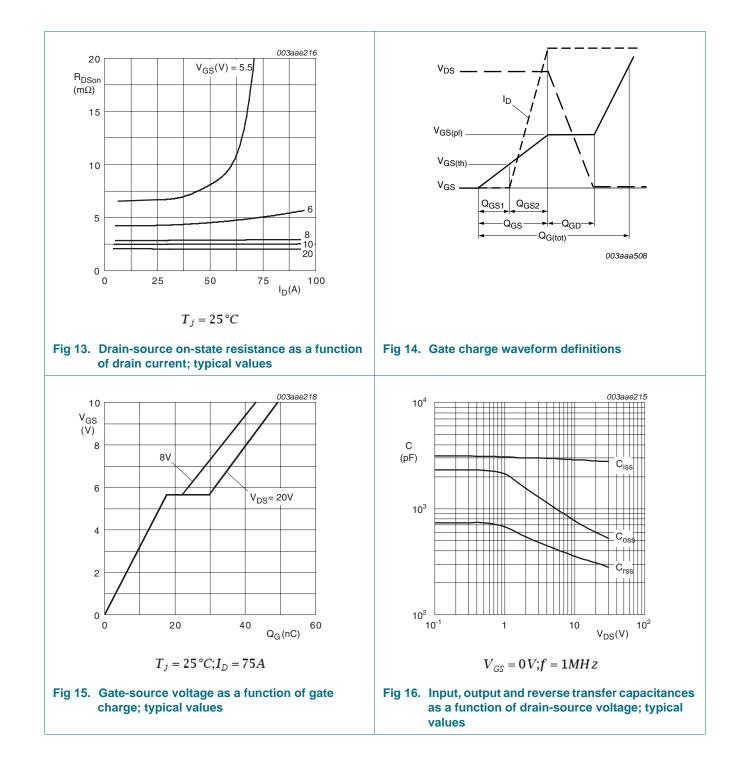
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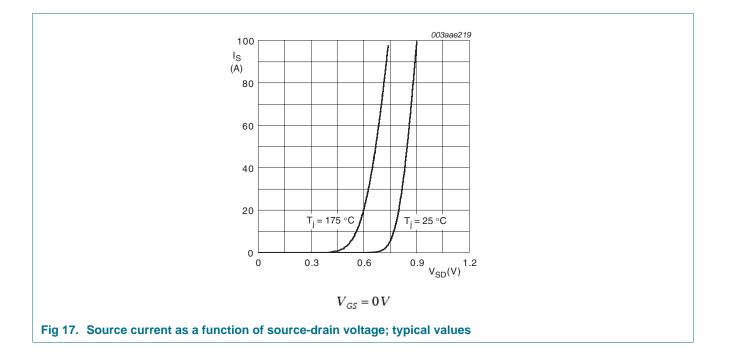
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7. Package outline

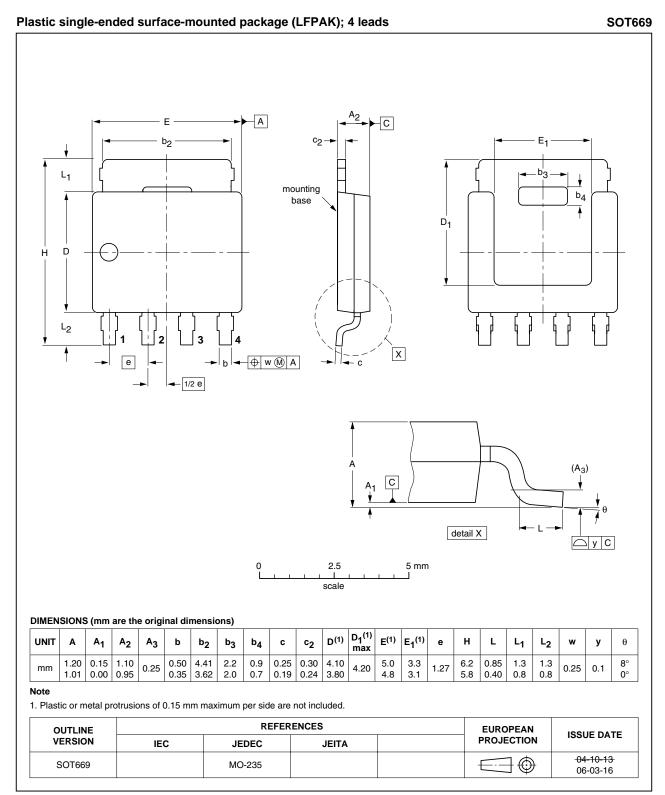


Fig 18. Package outline SOT669 (LFPAK)

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8. Revision history

Table 7.	Revision history	
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Document ID	Release date	Data sheet status	Change notice	Supersedes
PSMN3R3-40YS v.4	20101025	Product data sheet	-	PSMN3R3-40YS v.3
Modifications:	 Various changes 	to content.		
PSMN3R3-40YS v.3	20100930	Product data sheet	-	PSMN3R3-40YS v.2

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9. Legal information

9.1 Data sheet status

Document status[1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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